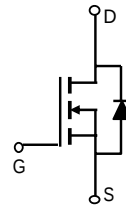
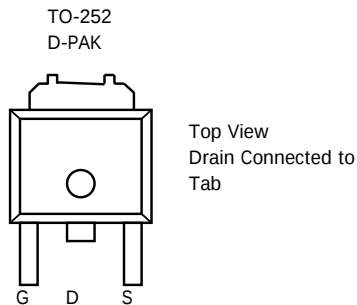


General Description

The AOD466 uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. This device is suitable for use in PWM, load switching and general purpose applications. *Standard Product AOD466 is Pb-free (meets ROHS & Sony 259 specifications). AOD466L is a Green Product ordering option. AOD466 and AOD466L are electrically identical.*

Features

$V_{DS} (V) = 25V$
 $I_D = 30A (V_{GS} = 10V)$
 $R_{DS(ON)} < 14 m\Omega (V_{GS} = 10V)$
 $R_{DS(ON)} < 24 m\Omega (V_{GS} = 4.5V)$


Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

Parameter	Symbol	Maximum	Units
Drain-Source Voltage	V_{DS}	25	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current ^G	I_D	30	A
$T_C=25^\circ C$		25	
$T_C=100^\circ C$	I_{DM}	70	
Pulsed Drain Current ^C	I_{AR}	20	A
Avalanche Current ^C	E_{AR}	20	mJ
Repetitive avalanche energy 0.1mH ^C	P_D	30	W
$T_C=25^\circ C$		15	
Power Dissipation ^B	P_{DSM}	2.5	W
$T_A=25^\circ C$		1.6	
Power Dissipation ^A	T_J, T_{STG}	-55 to 175	$^\circ C$
Junction and Storage Temperature Range			

Thermal Characteristics

Parameter	Symbol	Typ	Max	Units
Maximum Junction-to-Ambient ^A	$R_{\theta JA}$	15	20	$^\circ C/W$
$t \leq 10s$		41	50	$^\circ C/W$
Maximum Junction-to-Ambient ^A	$R_{\theta JC}$	3.6	5	$^\circ C/W$
Steady-State				
Maximum Junction-to-Case ^B				

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
STATIC PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V	25			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =20V, V _{GS} =0V T _J =55°C			1 5	μA
I _{GSS}	Gate-Body leakage current	V _{DS} =0V, V _{GS} =±20V			100	nA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250μA	1	1.8	2.5	V
I _{D(ON)}	On state drain current	V _{GS} =10V, V _{DS} =5V	70			A
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =30A		11.1	14	mΩ
		T _J =125°C		15.5		
		V _{GS} =4.5V, I _D =20A		19	24	mΩ
g _{FS}	Forward Transconductance	V _{DS} =5V, I _D =30A		30		S
V _{SD}	Diode Forward Voltage	I _S =1A, V _{GS} =0V		0.74	1	V
I _S	Maximum Body-Diode Continuous Current				25	A
DYNAMIC PARAMETERS						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =12.5V, f=1MHz		830	1000	pF
C _{oss}	Output Capacitance			224		pF
C _{rss}	Reverse Transfer Capacitance			127		pF
R _g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz		0.93	1.5	Ω
SWITCHING PARAMETERS						
Q _g (10V)	Total Gate Charge	V _{GS} =10V, V _{DS} =12.5V, I _D =30A		15.3	19	nC
Q _g (4.5V)	Total Gate Charge			7.4	9	nC
Q _{gs}	Gate Source Charge			2.7		nC
Q _{gd}	Gate Drain Charge			4.3		nC
t _{D(on)}	Turn-On DelayTime	V _{GS} =10V, V _{DS} =12.5V, R _L =0.42Ω, R _{GEN} =3Ω		8		ns
t _r	Turn-On Rise Time			11.7		ns
t _{D(off)}	Turn-Off DelayTime			30		ns
t _f	Turn-Off Fall Time			11		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =30A, dI/dt=100A/μs		23.5	30	ns
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =30A, dI/dt=100A/μs		12.8		nC

A: The value of R_{θJA} is measured with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C. The Power dissipation P_{DSM} is based on R_{θJA} and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175°C may be used if the PCB allows it.

B: The power dissipation P_D is based on T_{J(MAX)}=175°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C: Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=175°C.

D: The R_{θJA} is the sum of the thermal impedance from junction to case R_{θJC} and case to ambient.

E: The static characteristics in Figures 1 to 6 are obtained using <300 μs pulses, duty cycle 0.5% max.

F: These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=175°C.

G: The maximum current rating is limited by bond-wires.

H: These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C. The SOA curve provides a single pulse rating.

Rev 0 : Septemeber 2005

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

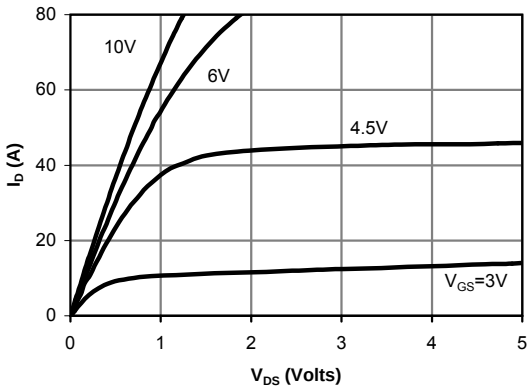


Fig 1: On-Region Characteristics

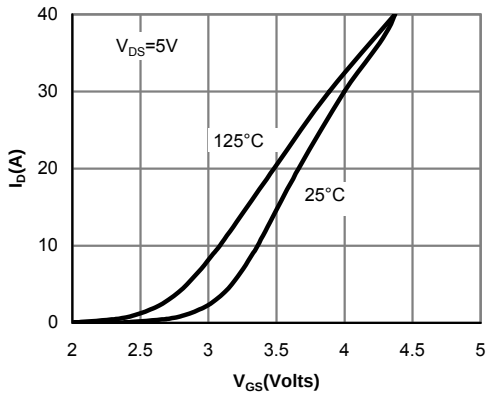


Figure 2: Transfer Characteristics

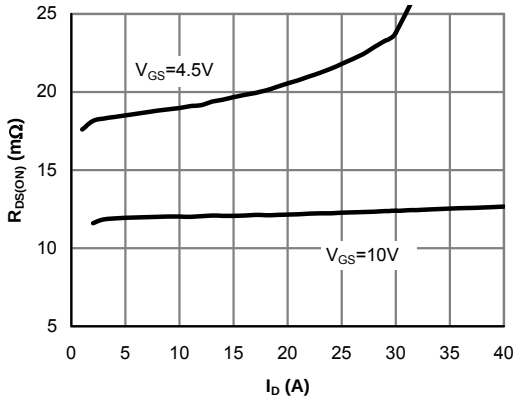


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

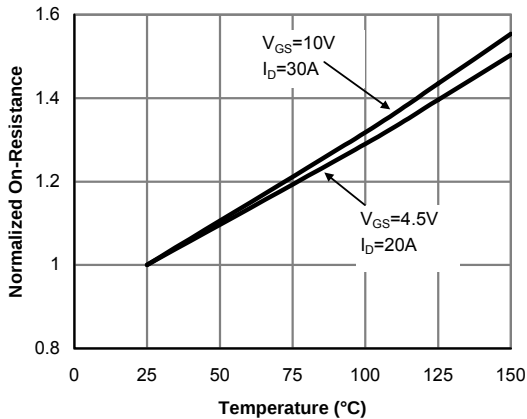


Figure 4: On-Resistance vs. Junction Temperature

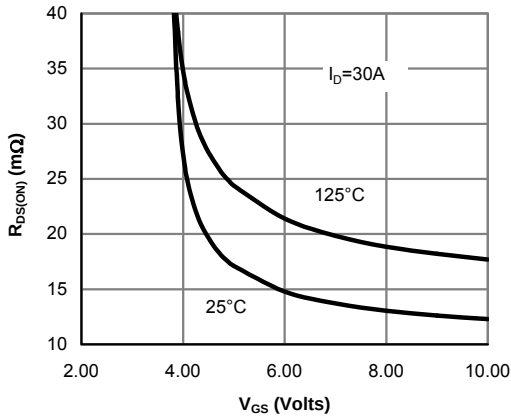


Figure 5: On-Resistance vs. Gate-Source Voltage

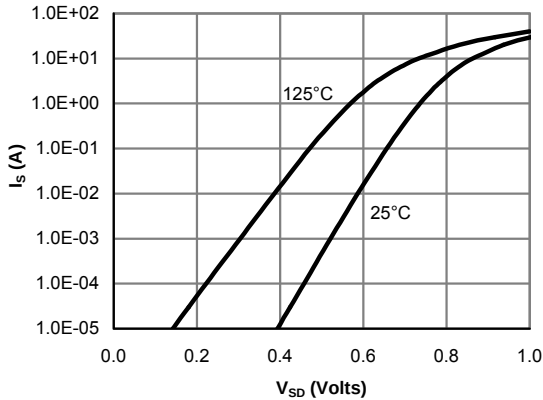
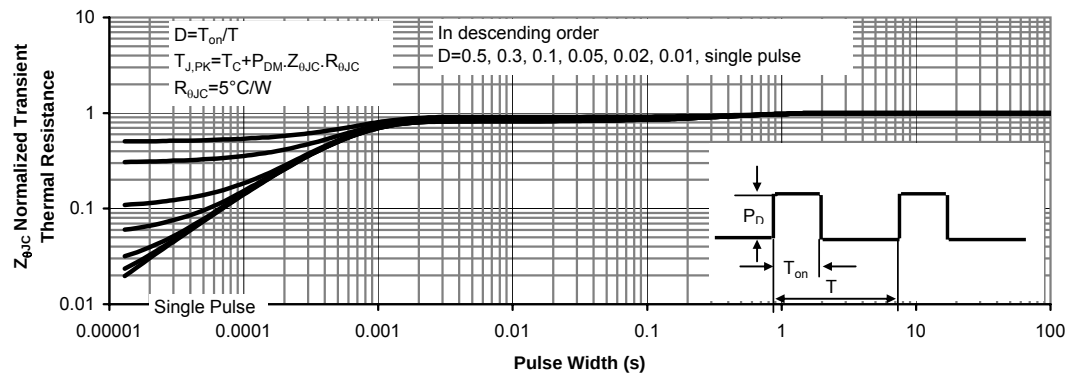
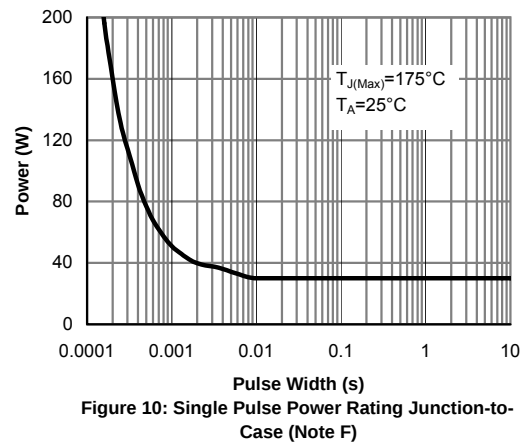
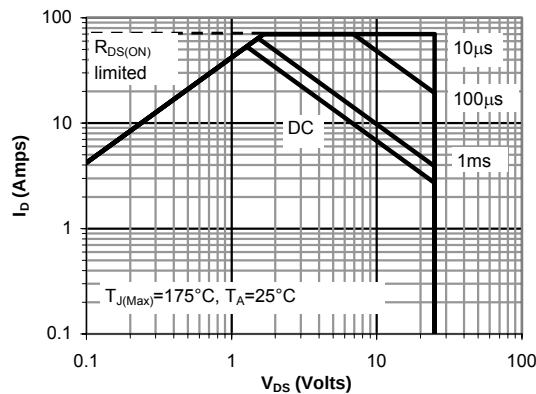
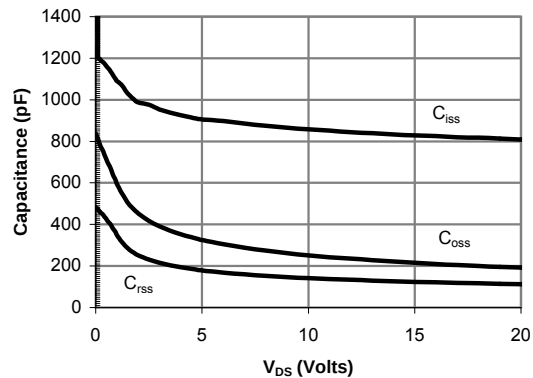
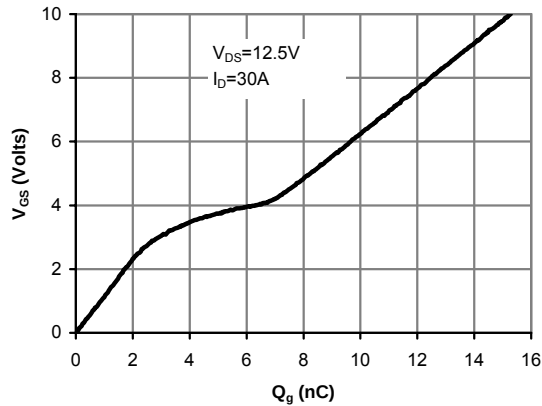


Figure 6: Body-Diode Characteristics

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

